

Notice of References Cited	Application/Control No. 10/825,351	Applicant(s)/Patent Under Reexamination HALL ET AL.	
	Examiner Steven J. Fulk	Art Unit 2891	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,528,327	03-2003	Nagano et al.	438/3
	B	US-2005/0148190	07-2005	Dubin et al.	438/700
	C	US-6,313,003	11-2001	Chen, Sheng-Hsiung	438/396
	D	US-6,239,022	05-2001	Seo et al.	438/629
	E	US-6,323,044	11-2001	Harris et al.	438/3
	F	US-6,221,775	04-2001	Ference et al.	438/691
	G	US-6,551,920	04-2003	Uchiyama et al.	438/624
	H	US-6,211,067	04-2001	Chen, Chang-Hui	438/633
	I	US-5,907,787	05-1999	Sato, Junichi	438/622
	J	US-2003/0003710	01-2003	Modak, Anjaneya	438/625
	K	US-5,244,534	09-1993	Yu et al.	438/672
	L	US-6,380,078	04-2002	Liu et al.	438/638
	M	US-6,767,837	07-2004	Sun et al.	438/714

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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